


<b>Search Notes</b>  	<b>Application/Control No.</b>  10500225	<b>Applicant(s)/Patent Under Reexamination</b>  YOSHIZATO ET AL.
	<b>Examiner</b>  Chin, Christopher L.	<b>Art Unit</b>  1641

SEARCHED			
Class	Subclass	Date	Examiner
Updated search history		12/13/2006	LYL
Updated search		8/31/08	CC

SEARCH NOTES		
Search Notes	Date	Examiner
Updated search history	12/13/2006	LYL

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
Same as above		8/31/08	CC

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